WINSTAR Display

OLED SPECIFICATION

Model No:

WEO012864GWPP3D00000

SPECIFICATION Version: C





(FOR CUSTOMER USE ONLY)

| SALES BY | APPROVED BY CHECKED BY | PREPARED BY |
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| | | |
| RELEASE DATE: | | |

APPROVAL FOR SPECIFICATIONS ONLY

APPROVAL FOR SPECIFICATIONS AND SAMPLE

MODEL NO:

| RECORDS OF REVISION | | | DOC. FIRST ISSUE |
|---------------------|------------|------------------------|---------------------------------------------------|
| VERSION | DATE | REVISED PAGE NO. | SUMMARY |
| 0 | 2018/07/02 | | First release |
| A | 2018/11/09 | | Add 6.3.3 Register Map |
| В | 2018/12/03 | | Modify Static electricity test Content of Test |
| С | 2019/09/02 | | Modify Precautions in use of OLED Modules |

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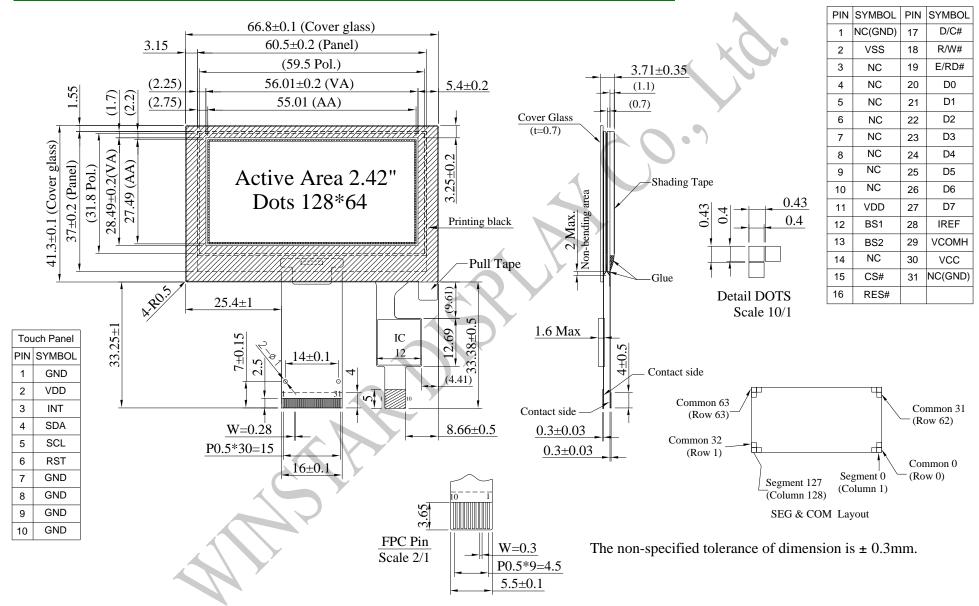
1.Module Classification Information \underline{W} \underline{E} \underline{O} $\underline{012864}$ \underline{G} \underline{W} \underline{P} \underline{P} $\underline{3}$ \underline{D} $\underline{0}$ $\underline{0$

| 1 | Brand : WINST | AR DISPLAY CORPORA | TION | | | | |
|----|-----------------|-------------------------|------------------------------------------------------------------------|--|--|--|--|
| 2 | E : OLED | | | | | | |
| | | H : COB Character | G : COB Graphic | | | | |
| | Diamles (Trues | O : COG | F : COG + FR | | | | |
| 3 | Display Type | P : COG + FR + PCB | X : TAB | | | | |
| | | A : COG + PCB | | | | | |
| 4 | Dot Matrix : 12 | 28 * 64 | | | | | |
| 5 | Serials code | | | | | | |
| | | A : Amber | R : Red C : Full Color | | | | |
| 6 | Emitting Color | B : Blue | W:White | | | | |
| 0 | | G : Green | L : Yellow | | | | |
| | | S : Sky Blue | X : Dual Color | | | | |
| 7 | Polarizer | P: With Polarizer; N: V | | | | | |
| | | A : Anti-glare Polarize | | | | | |
| 8 | Display Mode | | | | | | |
| 9 | Driver Voltage | 3:3.0~3.3V;5:5 | | | | | |
| 10 | Touch Panel | | el; T : Resistive TP; D : DCT Attached CTP; P; A : OCA Attached CTP | | | | |
| | | 0 : Standard | | | | | |
| | | 1 : Daylight Readable | | | | | |
| 11 | Product type | 2 : Transparent OLED | (TOLED) | | | | |
| | | 3 ; Flexible OLED (FO | LED) | | | | |
| | | 4 : OLED Lighting | | | | | |
| | | 0 : Standard | | | | | |
| 12 | Inspection | 2 : Special grade | | | | | |
| | Grade | C : Automotive grade | | | | | |
| | | ç | Y : Consumer grade | | | | |
| 13 | Option | · | PC ; H : Hot bar FPC; D : Demo Kit | | | | |
| 14 | Serial No. | Serial number(00~ZZ) | | | | | |

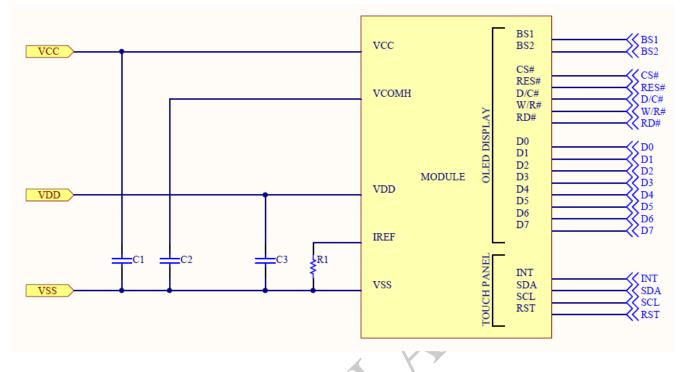
2.General Specification

| ltem | Dimension | Unit | | | | |
|------------------|---------------------------|------|--|--|--|--|
| Dot Matrix | 128 x 64 | - | | | | |
| Module dimension | 66.8 × 41.3 × 3.71 | mm | | | | |
| Active Area | 55.01 × 27.49 | mm | | | | |
| Pixel Size | 0.40 × 0.40 | mm | | | | |
| Pixel Pitch | 0.43 × 0.43 | mm | | | | |
| Display Mode | Passive Matrix | 0. | | | | |
| Display Color | Monochrome (White) | | | | | |
| Interface | 8Bits 68xx 80xx/ SPI/ I20 | > | | | | |
| Drive Duty | 1/64 Duty | | | | | |
| OLED IC | SSD1309 | | | | | |
| Size | 2.42inch | | | | | |
| CTP IC | GT911 | | | | | |
| Detect Point | 1 | | | | | |
| CTP Interface | I2C | | | | | |
| CTP FW Version: | VER95 | | | | | |
| Surface | Normal Glare | | | | | |

3. Contour Drawing & Block Diagram



3.1 Application recommendations



Recommended components: C1, C2 : 4.7uF/25V/0805 C3 : 1.0uF/16V/0603

OLED DISPLAY's Bus Interface selection: (Must be set the BS[2:1], refer to item 4) 8-bits 6800 and 8080 parallel, SPI, I2C

TOUCH PANEL'S INTERFACE : ONLY 12C INTERFACE.

Voltage at IREF \approx VCC - 3V. For VCC = 13V, IREF = 10uA: R1 = (Voltage at IREF - VSS) / IREF \approx (13 - 3)V / 10uA = 1MΩ

*For more information, please refer to Application Note provided by Winstar.

4. Interface Pin Function

| No. | Symbol | Function | | | | | |
|------|---------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--|--|--|--|--|
| 1 | NC(GND) | No connection | | | | | |
| 2 | VSS | Ground. | | | | | |
| 3-10 | NC | No connection | | | | | |
| 11 | VDD | Power supply pin for core logic operation | | | | | |
| 12 | BS1 | MCU bus interface selection pins. Select appropriate logic setting as described in the following table. BS2, BS1 and BS0 are pin select BS1 BS2 I2C 1 0 | | | | | |
| 13 | BS2 | 4-wire Serial 0 0 8-bit 68XX Parallel 0 1 8-bit 80XX Parallel 1 1 Note 1 1 (1) 0 is connected to VSS 0 (2) 1 is connected to VDD 0 | | | | | |
| 14 | NC | No connection | | | | | |
| 15 | CS# | This pin is the chip select input connecting to the MCU. The chip is enabled for MCU communication only when CS# is pulled LOW (active LOW). | | | | | |
| 16 | RES# | This pin is reset signal input. When the pin is pulled LOW, initialization of the chip is executed. Keep this pin pull HIGH during normal operation. | | | | | |
| 17 | D/C# | This pin is Data/Command control pin connecting to the MCU. When the pin is pulled HIGH, the data at D[7:0] will be interpreted as data. When the pin is pulled LOW, the data at D[7:0] will be transferred to a command register. In I2C mode, this pin acts as SA0 for slave address selection. When 3-wire serial interface is selected, this pin must be connected to VSS. | | | | | |
| 18 | R/W# | This pin is read / write control input pin connecting to the MCU interface. When 6800 interface mode is selected, this pin will be used as Read/Write (R/W#) selection input. Read mode will be carried out when this pin is pulled HIGH and write mode when LOW. When 8080 interface mode is selected, this pin will be the Write (WR#) input. Data write operation is initiated when this pin is pulled LOW and the chip is selected. When serial or I2C interface is selected, this pin must be connected to VSS. | | | | | |

| 19 | E/RD# | This pin is MCU interface input. When 6800 interface mode is selected, this pin will be used as the Enable (E) signal. Read/write operation is initiated when this pin is pulled HIGH and the chip is selected. When 8080 interface mode is selected, this pin receives the Read (RD#) signal. Read operation is initiated when this pin is pulled LOW and the chip is selected. When serial or I2C interface is selected, this pin must be connected to VSS. |
|-------|---------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 20~27 | D0~D7 | These pins are bi-directional data bus connecting to the MCU data bus. Unused pins are recommended to tie LOW. When serial interface mode is selected, D0 will be the serial clock input: SCLK; D1 will be the serial data input: SDIN and D2 should be kept NC. When I2C mode is selected, D2, D1 should be tied together and serve as SDAout, SDAin in application and D0 is the serial clock input, SCL. |
| 28 | IREF | This pin is the segment output current reference pin. IREF is supplied externally. |
| 29 | VCOMH | COM signal deselected voltage level. A capacitor should be connected between this pin and VSS. |
| 30 | VCC | Power supply for panel driving voltage. This is also the most positive power voltage supply pin. |
| 31 | NC(GND) | No connection |

CTP PIN Definition

| No. | Symbol | Function |
|-----|--------|-----------------------------------------------------------------------------------|
| 1 | GND | Power ground |
| 2 | VDD | Power supply |
| 3 | INT | Interrupt signal, active low, asserted to request Host start a new transaction |
| 4 | SDA | I2C data signal |
| 5 | SCL | I2C clock signal |
| 6 | RST | External reset signal, active low |
| 7 | GND | Power ground |
| 8 | GND | Power ground |
| 9 | GND | Power ground |
| 10 | GND | Power ground |

5.Absolute Maximum Ratings

| Parameter | Symbol | Min | Max | Unit | Notes |
|----------------------------|--------|------|------|------|-------|
| Supply Voltage for Logic | VDD | -0.3 | 3.47 | V | 1, 2 |
| Supply Voltage for Display | VCC | 0 | 15 | V | 1, 2 |
| Operating Temperature | TOP | -20 | +70 | °C | 0. |
| Storage Temperature | TSTG | -30 | +80 | °C | - |

Note 1: All the above voltages are on the basis of "VSS = 0V".

Note 2: When this module is used beyond the above absolute maximum ratings, permanent breakage of the module may occur. Also, for normal operations, it is desirable to use this module under the conditions according to Section 6 "Electrical Characteristics". If this module is used beyond these conditions, malfunctioning of the module can occur and the reliability of the module may deteriorate

6.Electrical Characteristics

6.1 DC Electrical Characteristics

| ltem | Symbol | Condition | Min | Тур | Max | Unit |
|------------------------------------|--------|------------|---------|-----|---------|------|
| Supply Voltage for Logic | VDD | _ | 2.8 | 3.0 | 3.3 | V |
| Supply Voltage for | VCC | _ | 12.5 | 13 | 13.5 | V |
| High Level Input | VIH | _ | 0.8×VDD | _ | | V |
| Low Level Input | VIL | — | _ | | 0.2×VDD | V |
| High Level Output | VOH | _ | 0.9×VDD | 0 | _ | V |
| Low Level Output | VOL | _ | _ | | 0.1×VDD | V |
| 50% Check Board operati Current | ng | VCC =13.0V | | 25 | 36 | mA |

6.2 OLED DISPLAY's Initial code

void Initial_SSD1309ZC(){

| Write_command(0xAE); | // Display Off |
|----------------------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Write_command(0xAD); Write_command(0x8e); | // Master Configuration // Select external VCC supply |
| Write_command(0xA8); Write_command(0x3F); | // Select Multiplex Ratio // Default => 0x3F (1/64 Duty) 0x1F(1/32 Duty) |
| Write_command(0xD3); Write_command(0x00); | //Setting Display Offset //00H Reset |
| Write_command(0x00); | //Set Column Address LSB |
| Write_command(0x10); | //Set Column Address MSB |
| Write_command(0x40); | //Set Display Start Line |
| Write_command(0x00); | //;Set Memory Addressing Mode Default => 0x02 //0x00 => Horizontal Addressing Mode |
| Write_command(0xA6); | //Set Normal Display |
| Write_command(0xDB); Write_command(0x3c); | //Set Deselect Vcomh level //~0.83xVCC |
| Write_command(0xA4); | //Entire Display ON |
| Write_command(0x81); Write_command(0xFF); | //Set Contrast Control for Bank 0 |
| Write_command(0xD5); Write_command(0xF0); | //SET DISPLAY CLOCK //105HZ |
| Write_command(0xD8); Write_command(0x05); | //Select Area color ON/OFF //MONO Mode and Low Power display Mode |
| Write_command(0xA1); | //Set Segment Re-Map Default => 0xA0 |
| Write_command(0xC8); | <pre>//0xA1 (0x01) => Column Address 0 Mapped to SEG131 //Set COM Output Scan Direction Default => 0xC0 //0xC8 (0x08) => Scan from COM63 to 0</pre> |
| Write_command(0xDA); Write_command(0x12); | //Set COM Hardware Configuration //Alternative COM Pin |
| Write_command(0xD9); Write_command(0xF1); Write_command(0xFF); | //Set Pre-Charge period //Refer to SPEC 34PAGE |
| Write_command(0xAF); | // Display ON |

}

6.3 TOUCH PANEL's application code.

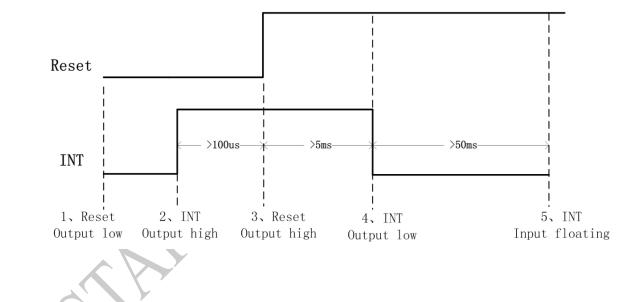
6.3.1

| 7-btis address | 8-bits write address | 8bits read address |
|----------------|----------------------|--------------------|
| 0x5D | 0xBA | 0xBB |
| 0x14 | 0x28 | 0x29 |

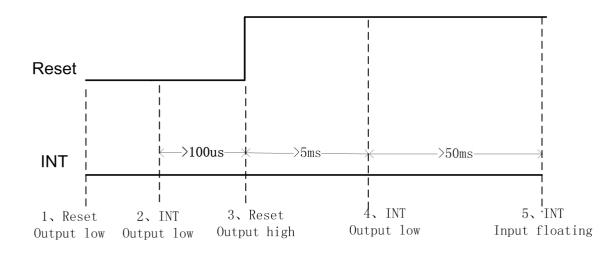
6.3.2 Power on for I2C address select

GT911 supports two I2C slave addresses: 0xBA/0xBB and 0x28/0x29. The host can select the address by changing the status of Reset and INT pins during the power-on initialization phase. See the diagram below for configuration methods and timings:

Timing for setting slave address to 0x28/0x29:



Timing for setting slave address to 0xBA/0xBB:



6.3.3 Register Map6.3.3.1 Real-time command (Write only)

| Addr | Name | bit7 | bit6 | bit5 | bit4 | bit3 | bit2 | bit1 | bit0 |
|--------|---------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------------------------------|------|------|------|---------------------|------------|
| 0x8040 | Command | 0: Read coordinates status; 1: Read diff data or raw data; 2: Read diff data or raw data;3: Reference capacitance update (Internal test); 4: Reference capacitance calibration(Internal test); 5: Screen off;6: Enter Charge mode; 7: Exit Charge mode8 : Gesture mode.0x20: Enter HotKnot Slave Approach mode0x21: Enter HotKnot Master Approach mode0x22: Enter Receive mode0x28: Exit Slave Approach mode0x29: Exit Master Approach mode0x24: Exit Receive mode0x2A: Exit Receive mode0x2A: Exit Receive mode0xAA: ESD protection mechanism enabled; driver writes 0xAA to 0x8040 and readsand checks the value of 0x8040 regularly; other values are invalid.ESD protection mechanism enabled; reset to 0 upon initialization; after that, driver | | | | | | | |
| 0x8041 | ESD_Check | ESD protection mechanism enabled; reset to 0 upon initialization; after that, driver writes 0xAA to 0x8040 and reads and checks the value of 0x8040 regularly. | | | | | | | |
| 0x8046 | Command_Check | For comm | • | er than 0x0' iting to 0x8 | | | | and to 0x80 ity. | 046 before |

6.3.3.2 Configuration information (R/W)

| Register | Config Data | bit7 | bit6 | bit5 | bit4 | bit3 | bit2 | bit1 | bit0 |
|----------|-----------------------------|---------------------|-----------------------------------------------|---------------------|-----------------|----------------------------------|-------------------------------|-----------------------------|-----------------------------------------------------|
| 0x8047 | Config_ Version | when the vers | sion number | of the new | release is late | er than that o | of the previou are numbere | us one, or e d sequentia | updated only qual to that of illy from 'A' to |
| 0x8048 | X Output Max (Low Byte) | | Resolution of X axis | | | | | | |
| 0x8049 | X Output Max (High Byte) | | | | Tesotation | i oi ii unio | | | |
| 0x804A | Y Output Max (Low Byte) | | | | Resolution | n of Y axis | | | |
| 0x804B | Y Output Max (High Byte) | | | | resolution | | | | |
| 0x804C | Touch Number | | Reserv | ved | | Т | ouch points | supported: | 1 to 5 |
| 0x804D | Module_ Switch1 | Driver_ Resersal | Sensor_ Resersal | Stretc | Stretch_rank | | Sito (Software | 00: rising 01: falling | edge |
| | | (Y2Y) | (X2X) | | | | noise reduction) | 02: Low le 03: High l | |
| 0x804E | Module_ switch2 | Reserv | ved | FirstFilte r_Dis | Reserved | | Touch_ Key | | |
| 0x804F | Shake_Count | De-jitter free | uency when | touch is being | g released | De-jitter | frequency wh | en touch is p | pressing down |
| 0x8050 | Filter | First_F | ilter | Norma | l_Filter (Filte | er threshold fo | r original coo | rdinates, coe | fficient is 4) |
| 0x8051 | Large_Touch | | | Nu | mber of large- | area touch po | ints | | |
| 0x8052 | Noise_ Reduction | | Reserv | ved | | Noise red | uction value (| 0-15 valid, c | coefficient is 1) |
| 0x8053 | Screen_ Touch_Level | | | Th | eshold for tou | ich to be detec | eted | | |
| 0x8054 | Screen_ Leave_Level | | | Th | reshold for tou | ich to be relea | sed | | |
| 0x8055 | Low_Power_ Control | | Reserv | ved | | Interval to | | wer consum 15s) | ption mode (0s |
| 0x8056 | Refresh_Rate | Pulse wie | 1th setting for | or gesture w | akeup | Coor | dinates report | rate (period | : 5+N ms) |
| 0x8057 | x_threshold | X coordinate | output thresh | | | st reported co dinates contin | | onfigured to | 0, GT911 will |
| 0x8058 | y_threshold | Y coordinate ou | tput threshold | | | | | figured to 0, | GT911 will keep |
| 0x8059 | X_Speed_Limit | | outputting coordinates continuously) Reserved | | | | | | |
| 0x805A | Y_Speed_Limit | | | | | | | | |

| 0x805B | | Space of | border top | (coefficient | : 32) | Space | of border b | pottom (coefficient: 32) |
|--------|-------------------------|------------------|---------------------------------|---------------|---------------------------------------------------------------------------------------|----------------|-------------|----------------------------------------------------------------------|
| 0x805C | Space | - | - | (coefficient | - | | | right (coefficient: 32) |
| 0x805D | Mini_Filter | Reserved | | | Mini filter configuration during line drawing process, configured as 0 indicates 4 | | | |
| 0x805E | Stretch_R0 | | | coe | fficient of St | retch space | 1 | |
| 0x805F | Stretch_R1 | | | co | efficient of S | Stretch space | 2 | |
| 0x8060 | Stretch_R2 | | coefficient of Stretch space 3 | | | | | |
| 0x8061 | Stretch_RM | | | The l | base of multi | ple stretch sp | baces | |
| 0x8062 | Drv_GroupA_ Num | All_Driving | Res | served | | Drive | r_Group_A | A_number |
| 0x8063 | Drv_GroupB_ Num | Reserve | ed | Dual_Fr eq | | Drive | r_Group_I | 3_number |
| 0x8064 | Sensor_Num | Sens | sor_Group | _B_Number | | | Sensor_G | roup_A_Number |
| 0x8065 | FreqA_factor | | | - | actor of drive ock Multiplie | | | • |
| 0x8066 | FreqB_factor | | | - | actor of driv ock Multiplie | | | - |
| 0x8067 | Pannel_ BitFreqL | | F | | | | | |
| 0x8068 | Pannel_ BitFreqH | Fundamental | Frequency | of Driver C | roups A and | B (1526HZ< | Fundame | ntal Frequency <14600Hz) |
| 0x8069 | Pannel_Sensor_ TimeL | Output Interval | between t | wo adjacent | drive signals | (unit: us); R | eserved (1 | used in beta version; invalid |
| 0x806A | Pannel_Sensor_ TimeH | | | | in a Re | elease) | | |
| 0x806B | Pannel_Tx_ Gain | R | eserved | | Pannel_Dr F 4 gain config | R values, |] | Pannel_DAC_Gain 0: Gain max. 7: Gain min. |
| 0x806C | Pannel_Rx_ Gain | Pannel_PG A_C | Pannel_ | PGA_R | Pannel_F (4 gain configu | values, | | Pannel_PGA_Gain in values, configurable) |
| 0x806D | Pannel_Dump_ Shift | Amplification f | actor of rav (2 ^N | | sture Mode | Amplific | | or of raw data on the touch anel (2^N) |
| 0x806E | Drv_Frame_ Control | Reserved | SubF | Frame_DrvN | um (maximu | m setting is | 17) | Repeat_Num (Accumulated sampling count) |
| 0x806F | Charging_Level_U | | el. The leve | el applicable | | node= origina | al level+co | ses the Touch_Level and nfiguration level. When riginal level. |

| 0x8070 | Module_ Switch3 | Reserved | Gesture_ Hop_ Dis | Strong_S mooth | | | | | | Shape_En | |
|--------|-----------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------------------------------------------------------|--------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------|-------------|------------------------|-----------------------|------------|---------------|
| 0x8071 | GESTURE_DIS | Valid d | istance for sl | ide-up/dov | wn wakeup Valid distance for slide-left/right wakeup | | | | eup | | |
| 0x8072 | Gesture_Long_ Press_Time | | The gesture | recognizin | ng process | sing abort | ting time p | period wl | hen long | touching | |
| 0x8073 | X/Y_Slope_Adjust | The adjustment parameter of X direction slope when using "four point trigonometric approximation algorithm" to calculate the coordinates (0: algorithm disabled) | | | The adjustment parameter of Y direction slope when using "four point trigonometric approximation algorithm" to calculate the coordinates (0: algorithm disabled) | | | metric ulate the | | | |
| 0x8074 | Gesture_Control | | ne for double ults to 1.5s v | · · | <u> </u> | | Gestu | _ | PGA_Gair onfigurab | | values, |
| 0x8075 | Gesture_Switch1 | Swipe left | Swipe up | Swipe right | | v | 0 | m | L | e | с |
| 0x8076 | Gesture_Switch2 | Swipe is valid only at the bottom of the TP | Z | s | , | ^ | > | v | | p | Swipe down |
| 0x8077 | Gesture_Refresh_R ate | | | Report | rate in G | esture mo | ode (perio | od is 5+r | ms) | | |
| 0x8078 | Gesture_Touch_ Level | | |] | Fouch thr | eshold in | Gesture n | node | | | |
| 0x8079 | NewGreenWake UpLevel | | Thre | shold for I | NewGree | n wakeup | of Gestu | re wakeu | p function | n | |
| 0x807A | Freq_Hopping_Star t | Start freq | uency for fre | | ind | icates100 | _ | | | , for exa | ample, 50 |
| 0x807B | Freq_Hopping_End | End frequ | iency for free | | ind | icates 300 | | | | for exa | mple, 150 |
| 0x807C | Noise_Detect_Time s | (Number of frequency | t_Stay_Time f tests taken o point in each s recommend | on each 1 noise | (Confirn | ned noise | level afte | | | ests, 1-63 | valid; 20 is |
| 0x807D | Hopping_Flag | Hopping_E n | Rang Ex | | Dis_Fo rce_Ref | Dela | ay_Hoppir | ng | (timeout | | detection, |
| 0x807E | Hopping_ Threshold | the interfer | ence value of | f current fr | ing is enabled only when frequency is greater than imum setting of this limit unit: second), Reserved Hopping_Hit_Threshold (Conditions for selecting optimal frequency: Current operating frequence interference- Minimum interference>S | | | optimal g frequency | | | |

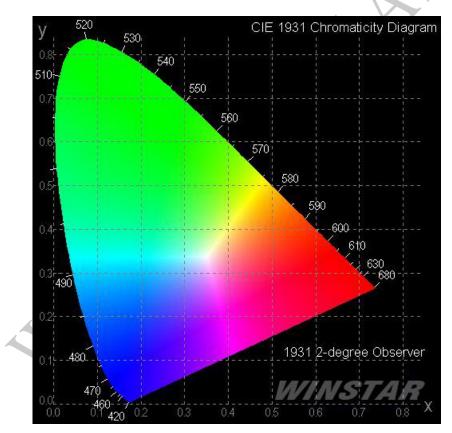
| | | | valuex4, then optimal frequency is selected and frequency hopping is |
|--------|----------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------|
| | Notes | | enabled) |
| 0x807F | Noise_ Threshold | Threshold to distinguish if there is interference (if the inter- this threshold, it is regarded as no inter- | 1 1 1 |
| | Threshold | When ESD causes the minimum interference point to be greater | |
| 0x8080 | Noise_Min_Thresh old | reduction treatment. Configured to 0 means this function is disable higher) has the equivalent effect. To enable this function, it is reco the minimum frequency point (LCD interference and common- normal interference. | d and configured to high value (such as 200 or ommended to set the value 5 to 20 higher than mode interference, whichever is greater) in |
| 0x8081 | NC | Reserved | |
| 0x8082 | Hopping_Sensor_G roup | Sections for Hopping Frequency Noise Detectio | n (4 sections recommended) |
| 0x8083 | Hopping_seg1_Nor malize | Seg1 Normalize coefficient (sampling val | ue *N / 128= Raw data) |
| 0x8084 | Hopping_seg1_Fact or | Seg1 Central point Fa | ctor |
| 0x8085 | Main_Clock_Ajdus t | Fine adjustment of IC main clock Frequency, v | vithin the range of -7 to +8 |
| 0x8086 | Hopping_seg2_Nor malize | Seg2 Normalize coefficient (sampling val | ue *N / 128= Raw data) |
| 0x8087 | Hopping_seg2_Fact or | Seg2 Central point Fa | ctor |
| 0x8088 | NC | Reserved | |
| 0x8089 | Hopping_seg3_Nor malize | Seg3 Normalize coefficient (sampling val | ue *N / 128= Raw data) |
| 0x808A | Hopping_seg3_Fact or | Seg3 Central point Fa | ctor |
| 0x808B | NC | Reserved | |
| 0x808C | Hopping_seg4_Nor malize | Seg4 Normalize coefficient (sampling val | ue *N / 128= Raw data) |
| 0x808D | Hopping_seg4_Fact or | Seg4 Central point Fa | ctor |
| 0x808E | NC | Reserved | |
| 0x808F | Hopping_seg5_Nor malize | Seg5 Normalize coefficient (sampling val | ue *N / 128= Raw data) |
| 0x8090 | Hopping_seg5_Fact or | Seg5 Central point Fa | ctor |
| 0x8091 | NC | Reserved | |
| 0x8092 | Hopping_seg6_Nor malize | Seg6 Normalize coefficient (sampling val | ue *N / 128= Raw data) |
| 0x8093 | Key 1 | Key 1 address: 0-255 | valid |

| | | (0 indicate | s no key is a | | | sses of all four | - | multiples of | 8, it means |
|--------|-----------------------|-------------|---------------------------------------|---------------------------------|--------------|--------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------|-------------------------------------------------------------------------|
| | | | | | | y design mann | - | | |
| | | | | | - | ss: 0-255 valid | | | |
| 0x8094 | Key 2 | (0 indica | tes no key is | available. W | hen the add | ess of all four | keys is the m | ultiples of 8, | it means |
| | | | | inc | lependent ke | ey design manr | ner) | | |
| | | | | | Key 3 addre | ss: 0-255 valid | l | | |
| 0x8095 | Key 3 | (0 indica | tes no key is | available. W | hen the add | ess of all four | keys is the m | ultiples of 8, | it means |
| | | | | inc | lependent ke | ey design manr | ner) | | |
| | | | | | Key 4 addre | ss: 0-255 valid | l | | |
| 0x8096 | Key 4 | (0 indica | tes no key is | available. W | hen the addr | ess of all four | keys is the m | ultiples of 8, | it means |
| | | | | inc | lependent ke | ey design manr | ner) | | |
| | | Time limi | t for long-pr | ess update (1 | s to 15s). | Key active ar | ea configuratio | on (single side) | : 0-15 valid |
| 0x8097 | Key_Area | Long-press | update is dis | sabled when o | configured | | | | |
| | | | to | 0. | | | | | |
| 0x8098 | Key_Touch_Level | | | | Touch key t | ouch threshold | l | | |
| 0x8099 | Key_Leave_Level | | | • | Fouch key re | elease threshole | d | | |
| 0x809A | Key_Sens | KeySen | s_1(sensitivit | y coefficient of | f Key 1) | KeySens | s_2 (sensitivity | coefficient of | f Key 2) |
| 0x809B | Key_Sens | KeySen | s_3(sensitivit | y coefficient of | f Key 3) | KeySens | s_4 (sensitivity | coefficient of | f Key 4) |
| | | The key 1 | estrain inter | val after finge | er leaves | Independe | ent adjacent k | ey restrain p | arameter |
| 0x809C | Key_Restrain | screen | screen (unit: 100ms), 0 means the key | | | | | | |
| | | suj | pression int | erval is 600m | s. | | | | |
| 0x809D | Key_Restrain_ Time | | Rese | rved | | slides to lea ms). Timin leaves the T this time into until the tou | y restrain time we at the bott g starts from TP. If there is erval, the touc the key is rele igured as 0, t | om of the TF the moment touch key ev ch key will b eased and tou | e (unit: 100 that finger eent within e restrained ched down |
| 0.0005 | GESTURE_ | Large-area | touch proce | ssing in Gest | ure mode (th | ne size of the to | | | |
| 0x809E | LARGE_TOUCH | | | | function | is disabled. | | | |
| 0x809F | NC | | | | Res | served | | | |
| 0x80A0 | NC | | | | Res | served | | | |
| 0x80A1 | Hotknot_Noise_ Map | Rese | rved | 200K | 250K | 300K | 350K | 400K | 450K |
| 0x80A2 | Link_Threshold | | | | Link_Noi | seThreshold | | | |
| 0x80A3 | Pxy_Threshold | | | | Pxy_Nois | seThreshold | | | |
| 0x80A4 | GHot_Dump_ Shift | | Reserved | | Rx_Self | Ampl | ification factor | or of raw Dat | a (2 ^N) |
| 0x80A5 | GHot_Rx_Gain | PGA_C | PG | A_R | Res | served | | Gain (8 level configured) | s to be |
| 0x80A6 | Freq_Gain0 | - | - | ation, calibrat lid when N=0 | | Ũ | al gain calibra s N/16. Inval | · | |

| 0x80A7 | Freq_Gain1 | 300K signal gain calibration, calibration volume is N/16. Invalid when N=0. | 350K signal gain calibration, calibration volume is N/16. Invalid when N=0. | | |
|------------------------|------------------------------|--------------------------------------------------------------------------------|--------------------------------------------------------------------------------|--|--|
| | | 200K signal gain calibration, calibration volume | 250K signal gain calibration, calibration volume | | |
| 0x80A8 | Freq_Gain2 | is $N/16$. Invalid when N=0. | is N/16. Invalid when N=0. | | |
| | | | 150K signal gain calibration, calibration volume | | |
| 0x80A9 | Freq Gain3 | Reserved | is N/16. Invalid when N=0. | | |
| 0x80AA | NC | Res | erved | | |
| 0x80AB | NC | | erved | | |
| 0x80AC | NC | Res | erved | | |
| 0x80AD | NC | Res | erved | | |
| 0x80AE | NC | | erved | | |
| 0x80AF | NC | Res | erved | | |
| 0x80B0 | NC | Res | erved | | |
| 0x80B1 | NC | Res | erved | | |
| 0x80B2 | NC | Res | erved | | |
| 0x80B3 | Combine_Dis | Distance for adjacent rectangles to be combined in Gesture mode | Distance for adjacent rectangles to be combined | | |
| 0x80B4 | Split_Set | Distance for a large-area rectangle to be split | Distance for a normal-size rectangle to be split | | |
| 0x80B5 | NC | Reserved | | | |
| 0x80B6 | NC | Res | erved | | |
| 0x80B7 to 0x80C4 | Sensor_CH0 to Sensor_CH13 | Channel number on chip corresponding to ITO Sensor | | | |
| 0x80C5 to 0x80D4 | NC | Res | erved | | |
| 0x80D5 to 0x80EE | Driver_CH0 to Driver_CH25 | Channel number on chip c | orresponding to ITO Driver | | |
| 0x80EF to 0x80FE | NC | Res | erved | | |
| 0x80FF | Config_Chksum | Configuration verification (checksum va | alue of the bytes from 0x8047 to 0x80FE) | | |
| 0x8100 | Config_Fresh | Configuration updated flag (| the flag is written by the host) | | |
| X | (A) | | | | |

7.Optical Characteristics

| Item | Symbol | Condition | Min | Тур | Max | Unit |
|-----------------------|------------|-----------------|--------|------|------|-------|
| View Angle | (V)θ | _ | 160 | — | | deg |
| view Angle | (H)φ | _ | 160 | — | 1 | deg |
| Contrast Ratio | CR | Dark | 2000:1 | _ | X | • |
| Deenenee Time | T rise | _ | _ | 10 | | μs |
| Response Time | T fall | _ | _ | 10 | Y_ | μs |
| Display with 50% | % check Bo | oard Brightness | 60 | 80 | _ | cd/m2 |
| CIEx(White) (CIE1931) | | | 0.24 | 0.28 | 0.32 | _ |
| CIEy(White) | | (CIE1931) | 0.28 | 0.32 | 0.36 | — |



8.OLED Lifetime

| ITEM | Conditions | Min | Тур | Remark |
|------------------------|------------------------------------------------------------------|------------|-----|--------|
| Operating Life Time | Ta=25°C / Initial 50% check board brightness Typical Value | 20,000 Hrs | _ | Note |

Notes:

- 1. Life time is defined the amount of time when the luminance has decayed to <50% of the initial value.
- 2. This analysis method uses life data obtained under accelerated conditions to extrapolate an estimated probability density function (*pdf*) for the product under normal use conditions.
- 3. Screen saving mode will extend OLED lifetime.

9.Reliability

Content of Reliability Test

| Test Item | Content of Test | Test Condition | Applicable Standard |
|-----------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------|-----------------------------------------------------------------------------|------------------------|
| High Temperature storage | Endurance test applying the high storage temperature for a long time. | 80°C 240hrs | |
| Low Temperature storage | Endurance test applying the low storage temperature for a long time. | -30°C 240hrs | $-\langle \rangle$ |
| High Temperature Operation | Endurance test applying the electric stress (Voltage & Current) and the thermal stress to the element for a long time. | 70°C 240hrs | |
| Low Temperature Operation | Endurance test applying the electric stress under low temperature for a long time. | -20°C 240hrs | |
| High Temperature/ Humidity Storage | Endurance test applying the high temperature and high humidity storage for a long time. | 60°C,90%RH 240hrs | |
| High Temperature/ Humidity Operation | Endurance test applying the high temperature and high humidity Operation for a long time. | 60°C,90%RH 120hrs | |
| Temperature Cycle | Endurance test applying the low and high temperature cycle. -30°C 25°C 80°C 30min 5min 30min | -30°C /80°C 30 cycles | |
| Mechanical Te | st | | |
| Vibration test | Endurance test applying the vibration during transportation and using. | Frequency:10~55Hz amplitude:1.5mm Time:0.5hrs/axis Test axis:X,Y,Z | |
| Others | 1 m | 1 | |
| Static electricity test | Endurance test applying the electric stress to the finished product housing. | Air Discharge model ±4kv,10 times | |

*** Supply voltage for OLED system =Operating voltage at $25^{\circ}C$

Test and measurement conditions

- 1. All measurements shall not be started until the specimens attain to temperature stability. After the completion of the described reliability test, the samples were left at room temperature for 2 hrs prior to conducting the failure test at 23±5°C; 55±15% RH.
- 2. All-pixels-on is used as operation test pattern.
- 3. The degradation of Polarizer are ignored for High Temperature storage, High Temperature/ Humidity Storage, Temperature Cycle

Evaluation criteria

- 1. The function test is OK.
- 2. No observable defects.
- 3. Luminance: > 50% of initial value.
- 4. Current consumption: within \pm 50% of initial value.

APPENDIX:

RESIDUE IMAGE

Because the pixels are lighted in different time, the luminance of active pixels may reduce or differ from inactive pixels. Therefore, the residue image will occur. To avoid the residue image, every pixel needs to be lighted up uniformly.



10.Inspection specification

Inspection Standard:

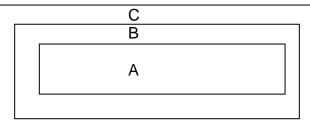
MIL-STD-105E table normal inspection single sample level II.

Definition

1 Major defect : The defect that greatly affect the usability of product.

2 Minor defect : The other defects, such as cosmetic defects, etc.

Definition of inspection zone:



Zone A: Active Area

Zone B: Viewing Area except Zone A

Zone C: Outside Viewing Area

Note: As a general rule, visual defects in Zone C are permissible, when it is no trouble of quality and assembly to customer`s product.

Inspection Methods

- 1 The general inspection : Under fluorescent light illumination: 750~1500 Lux, about 30cm viewing distance, within 45° viewing angle, under 25±5°C.
- 2 The luminance and color coordinate inspection : By SR-3 or BM-7 or the equal equipments, in the dark room, under 25±5°C.

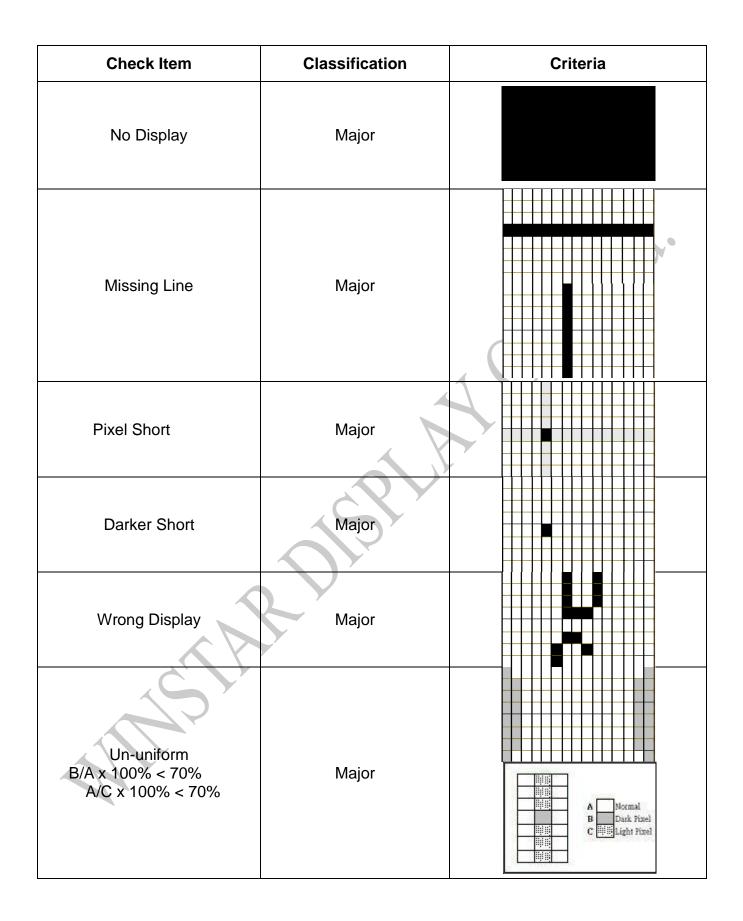
| NO | ltem | Criterion | AQL |
|----|---------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|
| 01 | Electrical Testing | 1.1 Missing vertical, horizontal segment, segment contrast defect. 1.2 Missing character, dot or icon. 1.3 Display malfunction. 1.4 No function or no display. 1.5 Current consumption exceeds product specifications. 1.6 OLED viewing angle defect. 1.7 Mixed product types. 1.8 Contrast defect. | 0.65 |
| 02 | Black or white spots on OLED (display only) | 2.1 White and black spots on display ≤ 0.25mm, no more than three white or black spots present. 2.2 Densely spaced: No more than two spots or lines within 3mm. | 2.5 |

| NO | Item | | Criterio | า | | AQL |
|----|-------------------------|-------------------------------------------|--------------------------------------------------------------|--------------------|-------|-----|
| | OLED black | 3.1 Round type : As following | 0175 | Accortable | | |
| | spots, white spots, | drawing Φ=(x + y) / 2 | SIZE | Acceptable QTY | Zone | |
| | contaminati on (non- | - → ^X ← <u>↓</u> | Ф≦0.10 | Accept no dense | A+ B, | 2.5 |
| | display) | | $0.10 \! < \! \Phi \! \le \! 0.20$ | 2 | A+ B | |
| | | Ť | 0.20<Φ≦0.25 | 1 | A+ B | |
| | | | 0.25<Φ | | A+ B | |
| | | 3.2 Line type : (As | following drawing |) | | |
| 03 | | \sim | | (0.) | | |
| | | → L +← | | | | |
| | | | | | | |
| | | Lengtl | n Width | Acceptable Q TY | Zone | 2.5 |
| | | | W≦0.02 | Accept no dense | A+B | |
| | | L≦3.(| | - 2 | A+B | |
| | | L≦2.5 | | 15 | A+B | |
| | | | 0.05 <w< td=""><td>As round type</td><td></td><td></td></w<> | As round type | | |
| | | 2' | | | | |
| | | If bubbles are | Size Φ | Acceptable Q TY | Zone | |
| | | visible, judge | Φ≦0.20 | Accept no dense | A+B | |
| | | using black spot | $0.20 \! < \! \Phi \! \le \! 0.50$ | 3 | A+B | |
| 04 | Polarizer | specifications, not easy to find, | $0.50 \! < \! \Phi \! \le \! 1.00$ | 2 | A+B | 2.5 |
| 04 | bubbles | must check in | 1.00<Φ | 0 | A+B | 2.0 |
| | | specify | Total Q TY | 3 | | |
| | | direction. | | | | |
| 05 | Scratches | Follow NO.3 OLEI | D black spots. whit | e spots, contamina | tion. | |
| | ~ ~ ~ ~ ~ ~ | | | | | |

| NO | Item | Criterion | AQL |
|----|------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|
| 06 | Chipped glass | Symbols Define: x: Chip length t: Glass thickness k: Seal width | 2.5 |
| 06 | Glass crack | $\begin{array}{c} \text{Symbols :} \\ \text{x: Chip length} & \text{y: Chip width} & \text{z: Chip thickness} \\ \text{k: Seal width} & \text{t: Glass thickness} & \text{a: OLED side length} \\ \text{L: Electrode pad length} \\ \text{6.2 Protrusion over terminal :} \\ \text{6.2.1 Chip on electrode pad :} \\ \hline \\ $ | 2.5 |

| NO | Item | Criterion | AQL | |
|--------------------------------------|-----------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------|--|
| | | 6.2.2 Non-conductive portion: | | |
| 06 | Glass crack | y y x y: Chip width x: Chip length z: Chip thickness | | |
| | | $y \le L$ $x \le 1/8a$ $0 < z \le t$ | | |
| | | If the chipped area touches the ITO terminal, over 2/3 of the ITO must remain and be inspected according to electrode terminal specifications. If the product will be heat sealed by the customer, the alignment mark not be damaged. 6.2.3 Substrate protuberance and internal crack. | 2.5 | |
| | | y: width x: length $y \le 1/3L$ $x \le a$ | | |
| 07 | Cracked glass | The OLED with extensive crack is not acceptable. | 2.5 | |
| 08 | Backlight elements | 8.1 Illumination source flickers when lit.8.2 Spots or scratched that appear when lit must be judged. Using OLED spot, lines and contamination standards. | 0.65 2.5 | |
| | | 8.3 Backlight doesn't light or color wrong. | 0.65 | |
| 09 | Bezel | 9.1 Bezel may not have rust, be deformed or have fingerprints, stains or other contamination.9.2 Bezel must comply with job specifications. | 2.5 0.65 | |
| | PCB, COB | 10.1 COB seal may not have pinholes larger than 0.2mm or contamination. 10.2 COB seal surface may not have pinholes through to the IC. 10.3 The height of the COB should not exceed the height | 2.5 2.5 0.65 | |
| 10 | | indicated in the assembly diagram. 10.4 There may not be more than 2mm of sealant outside the seal area on the PCB. And there should be no more than three places. | 2.5 | |
| | | 10.5 No oxidation or contamination PCB terminals.10.6 Parts on PCB must be the same as on the production characteristic chart. There should be no wrong parts, missing | 2.5 0.65 | |
| | | parts or excess parts. 10.7 The jumper on the PCB should conform to the product characteristic chart. | 0.65 | |
| | | 10.8 If solder gets on bezel tab pads, OLED pad, zebra pad or screw hold pad, make sure it is smoothed down. | 2.5 | |
| ▶▶▶ \A/INICTAD WE0012864GW/PP3D00000 | | | | |

| NO | Item | Criterion | AQL |
|----|-----------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------------------------------------------------------------------------|
| 11 | Soldering | 11.1 No un-melted solder paste may be present on the PCB. 11.2 No cold solder joints, missing solder connections, oxidation or icicle. 11.3 No residue or solder balls on PCB. 11.4 No short circuits in components on PCB. | 2.5 2.5 2.5 0.65 |
| 12 | General appearance | 12.1 No oxidation, contamination, curves or, bends on interface Pin (OLB) of TCP. 12.2 No cracks on interface pin (OLB) of TCP. 12.3 No contamination, solder residue or solder balls on product. 12.4 The IC on the TCP may not be damaged, circuits. 12.5 The uppermost edge of the protective strip on the interface pin must be present or look as if it cause the interface pin to sever. 12.6 The residual rosin or tin oil of soldering (component or chip component) is not burned into brown or black color. 12.7 Sealant on top of the ITO circuit has not hardened. 12.8 Pin type must match type in specification sheet. 12.9 OLED pin loose or missing pins. 12.10 Product packaging must the same as specified on packaging specification sheet. 12.11 Product dimension and structure must conform to product specification sheet. | 2.5 0.65 2.5 2.5 2.5 2.5 2.5 2.5 0.65 0.65 0.65 0.65 |



11.Precautions in use of OLED Modules

Modules

- (1) Avoid applying excessive shocks to module or making any alterations or modifications to it.
- (2) Don't make extra holes on the printed circuit board, change the components or modify its shape of OLED display module.
- (3) Don't disassemble the OLED display module.
- (4) Do not apply input signals while the logic power is off.
- (5) Don't operate it above the absolute maximum rating.
- (6) Don't drop, bend or twist OLED display module.
- (7) Soldering: only to the I/O terminals.
- (8) Hot-Bar FPC soldering condition: 280~350C, less than 5 seconds.
- (9) Winstar has the right to change the passive components (Resistors, capacitors and other passive components will have different appearance and color caused by the different supplier.) and change the PCB Rev. (In order to satisfy the supplying stability, management optimization and the best product performance...etc, under the premise of not affecting the electrical characteristics and external dimensions, Winstar have the right to modify the version.)
- (10) Winstar has the right to upgrade or modify the product function.

11.1. Handling Precautions

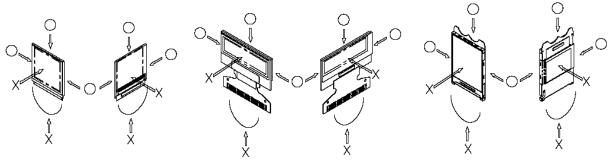
- (1) Since the display panel is being made of glass, do not apply mechanical impacts such as dropping from a high position.
- (2) If the display panel is broken by some accident and the internal organic substance leaks out, be careful not to inhale nor lick the organic substance.
- (3) If pressure is applied to the display surface or its neighborhood of the OLED display module, the cell structure may be damaged. So, be careful not to apply pressure to these sections.
- (4) The polarizer covering the surface of the OLED display module is soft and easily scratched.
- (5) When the surface of the polarizer of the OLED display module has soil, clean the surface. It takes advantage by using following adhesion tape.
 - * Scotch Mending Tape No. 810 or an equivalent

Never try to breathe upon the soiled surface nor wipe the surface using cloth containing solvent such as ethyl alcohol, since the surface of the polarizer will become cloudy.

Also, pay attention that the following liquid and solvent may spoil the polarizer:

- * Water
- * Ketone
- * Aromatic Solvents
- (6) Protection film is being applied to the surface of the display panel and removes the protection film before assembling it. At this time, if the OLED display module has been stored for a long period of time, residue adhesive material of the protection film may remain on the surface of the display panel after removed of the film. In such case, remove the residue material by the method introduced in the above Section 5.
- (7) Do not touch the following sections whenever possible while handling the OLED display modules.
 - * Pins and electrodes
 - * Pattern layouts such as the TCP & FPC
- (8) Hold OLED display module very carefully when placing OLED display module into the System housing. Do not apply excessive stress or pressure to OLED display module. And, do not over bend the film with electrode pattern layouts. These stresses will influence the

display performance. Also, secure sufficient rigidity for the outer cases.



- (9) Do not apply stress to the LSI chips and the surrounding molded sections.
- (10) Pay sufficient attention to the working environments when handing OLED display modules to prevent occurrence of element breakage accidents by static electricity.
 - * Be sure to make human body grounding when handling OLED display modules.
 - * Be sure to ground tools to use or assembly such as soldering irons.

* To suppress generation of static electricity, avoid carrying out assembly work under dry environments.

* Protective film is being applied to the surface of the display panel of the OLED display module. Be careful since static electricity may be generated when exfoliating the protective film.

11.2. Storage Precautions

- (1) When storing OLED display modules, put them in static electricity preventive bags to avoid be directly exposed to sun or lights of fluorescent lamps. (We recommend you to store these modules in the packaged state when they were shipped from Winstar. At that time, be careful not to let water drops adhere to the packages or bags.)
- (2) When the OLED display module is being dewed or when it is placed under high temperature or high humidity environments, the electrodes may be corroded if electric current is applied. Please store it in clean environment.

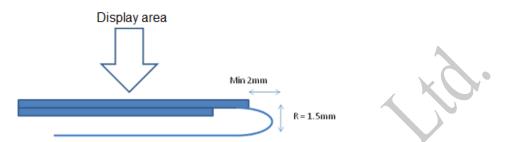
11.3. Designing Precautions

- (1) The absolute maximum ratings are the ratings which cannot be exceeded for OLED display module, and if these values are exceeded, OLED display module may be damaged.
- (2) To prevent occurrence of malfunctioning by noise, pay attention to satisfy the VIL and VIH specification and to make the signal line cable as short as possible.
- (3) We recommend you to install excess current preventive unit (fuses, etc.) to the power circuit (VDD / VCC). (Recommend value: 0.5A)
- (4) Pay sufficient attention to avoid occurrence of mutual noise interference with the nearby devices.
- (5) As for EMI, take necessary measures on the equipment side basically.
- (6) If the power supplied to the OLED display module is forcibly shut down by such errors as taking out the main battery while the OLED display panel is in operation, we cannot guarantee the quality of this OLED display module.

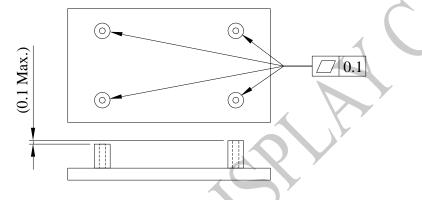
* Connection (contact) to any other potential than the above may lead to rupture of the IC.

- (7) If this OLED driver is exposed to light, malfunctioning may occur and semiconductor elements may change their characteristics.
- (8) The internal status may be changed, if excessive external noise enters into the module. Therefore, it is necessary to take appropriate measures to suppress noise generation or to protect module from influences of noise on the system design.

- (9) We recommend you to make periodical refreshment of the operation statuses (re-setting of the commands and re-transference of the display data) to cope with catastrophic noise.
- (10) It's pretty common to use "Screen Saver" to extend the lifetime and Don't use the same image for long time in real application. When an OLED display module is operated for a long of time with fixed pattern, an afterimage or slight contrast deviation may occur.
- (11) The limitation of FPC and Film bending.



(12) The module should be fixed balanced into the housing, or the module may be twisted.



11.4. Precautions when disposing of the OLED display modules

(1) Request the qualified companies to handle industrial wastes when disposing of the OLED display modules. Or, when burning them, be sure to observe the environmental and hygienic laws and regulations.